

Polar[™] HiPerFET Power MOSFET

IXFK 180N15P IXFX 180N15P

N-Channel Enhancement Mode Fast Intrinsic Diode Avalanche Rated

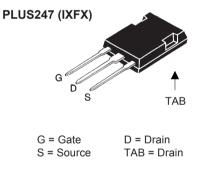


V _{DSS}	=	150	V
I _{D25}	=	180	Α
$R_{DS(on)}$	≤	11	$m\Omega$
t _{rr}		200	

			03
Symbol	Test Conditions	Maximum	Ratings
V _{DSS} V _{DGR}	$T_J = 25^{\circ} \text{ C to } 175^{\circ} \text{ C}$ $T_J = 25^{\circ} \text{ C to } 175^{\circ} \text{ C}; R_{GS} = 1 \text{ M}\Omega$	150 150	V V
V _{DS} V _{GSM}	Continuous Transient	±20 ±30	V V
I _{D25}	T _C =25°C	180	Α
I _{D(RMS)}	External lead current limit	75	Α
I _{DM}	$T_{\rm C}$ = 25° C, pulse width limited by $T_{\rm JM}$	380	Α
I _{AR}	T _C = 25° C	60	А
E _{AR}	T _C =25°C	100	mJ
E _{AS}	T _C = 25° C	4	J
dv/dt	$I_{S} \leq I_{DM}$, di/dt ≤ 100 A/ μ s, $V_{DD} \leq V_{DSS}$ $T_{J} \leq 150^{\circ}$ C, $R_{G} = 4$ Ω	10	V/ns
$\overline{P_{D}}$	T _C =25°C	830	W
T _J		-55 +175	°C
T _{JM}		175	°C
T _{stg}		-55 +150	°C
T _L	1.6 mm (0.062 in.) from case for 10 s	300	°C
T _{SOLD}	Plastic body for 10 s	260	°C
M _d	Mounting torque (IXFK)	1.13/10	Nm/lb.in.
F _c	Mounting Force (IXFX)	20120/4.525	N/lb
Weight	TO-264 (IXFK)	10	g
	PLUS247 (IXFX)	6	g

G	1
DS	TAB

TO-264 (IXFK)



Symbol $(T_J = 25^{\circ} C, t)$	Test Conditions unless otherwise specified)		Ch Min.	aracteri Typ.	istic Va Max	
BV _{DSS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		150			V
V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 4 \text{ mA}$		2.5		5.0	V
GSS	$V_{GS} = \pm 20 V_{DC}, V_{DS} = 0$				±200	nA
I _{DSS}	$V_{DS} = V_{DSS}$ $V_{GS} = 0 V$	T _J = 150° C			25 250	μA μA
R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_{D} = 0.5 I_{D25}$ Note 1				11	mΩ

Features

- ¹ International standard packages
- Unclamped Inductive Switching (UIS) rated
- ¹ Low package inductance
 - easy to drive and to protect

Advantages

- ^I Easy to mount
- Space savings
- High power density

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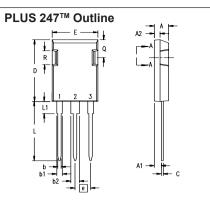
Symbo	ol	Test Conditions (T, = 25° C			ristic Values ise specified)
		. J	Min.	Тур.	Max.
g_{fs}		V_{DS} = 10 V; I_{D} = 0.5 I_{D25} , Note 1	55	86	S
\mathbf{C}_{iss})			7000	pF
C _{oss}	}	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$		2250	pF
C _{rss}	J			515	pF
$\mathbf{t}_{d(on)}$)			30	ns
t _r		$V_{GS} = 10 \text{ V}, V_{DS} = 0.5 V_{DSS}, I_{D} = 60 \text{ A}$		32	ns
$\mathbf{t}_{d(off)}$	($R_{_{\rm G}}$ = 3.3 Ω (External)		150	ns
t,)			36	ns
Q _{g(on)})			240	nC
\mathbf{Q}_{gs}	}	$V_{GS} = 10 \text{ V}, V_{DS} = 0.5 \text{ V}_{DSS}, I_{D} = 0.5 \text{ I}_{D25}$		55	nC
\mathbf{Q}_{gd}	J			140	nC
R _{thJC}		•			0.18° C/W
\mathbf{R}_{thCS}				0.15	° C/W

Source-Drain Diode

Characteristic Values (T₁ = 25°C, unless otherwise specified)

Symbol	Test Conditions Min.	. Тур.	Max.	
Is	$V_{GS} = 0 V$		180	Α
I _{SM}	Repetitive		380	Α
V _{SD}	$I_F = 90A$, $V_{GS} = 0 V$, Note 1		1.3	V
t _{rr} Q _{RM}	$I_F = 25 \text{ A}, -\text{di/dt} = 100 \text{ A/}\mu\text{s}$ $V_R = 100 \text{ V}, V_{GS} = 0 \text{ V}$	150 0.6	200	ns μC

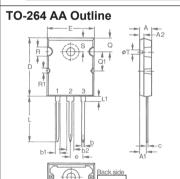
Note 1: Pulse test, t \leq 300 μ s, duty cycle d \leq 2 %



Terminals: 1 - Gate

- 2 Drain (Collector)
- 3 Source (Emitter) 4 Drain (Collector)

Dim.	Millimeter		Inches	
	Min.	Max.	Min.	Max.
Α	4.83	5.21	.190	.205
A,	2.29	2.54	.090	.100
A ₂	1.91	2.16	.075	.085
b	1.14	1.40	.045	.055
b₁	1.91	2.13	.075	.084
b ₂	2.92	3.12	.115	.123
С	0.61	0.80	.024	.031
D	20.80	21.34	.819	.840
E	15.75	16.13	.620	.635
е	5.45 BSC		.215 BSC	
L	19.81	20.32	.780	.800
L1	3.81	4.32	.150	.170
Q	5.59	6.20	.220	0.244
R	4.32	4.83	.170	.190



Dim. Millimeter		Inc	hes	
Diiii.	Min.	Max.	Min.	Max.
Α	4.82	5.13	.190	.202
A1	2.54	2.89	.100	.114
A2	2.00	2.10	.079	.083
b	1.12	1.42	.044	.056
b1	2.39	2.69	.094	.106
b2	2.90	3.09	.114	.122
С	0.53	0.83	.021	.033
D	25.91	26.16	1.020	1.030
Е	19.81	19.96	.780	.786
е	5.46	BSC	.215 BSC	
J	0.00	0.25	.000	.010
K	0.00	0.25	.000	.010
L	20.32	20.83	.800	.820
L1	2.29	2.59	.090	.102
Р	3.17	3.66	.125	.144
Q	6.07	6.27	.239	.247
Q1	8.38	8.69	.330	.342
R	3.81	4.32	.150	.170
R1	1.78	2.29	.070	.090
S	6.04	6.30	.238	.248
Т	1.57	1.83	.062	.072

Fig. 1. Output Characteristics @ 25°C

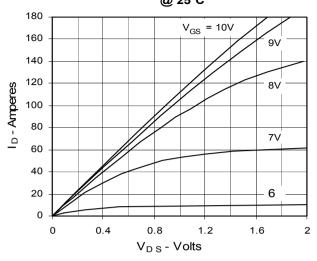


Fig. 3. Output Characteristics @ 150°C

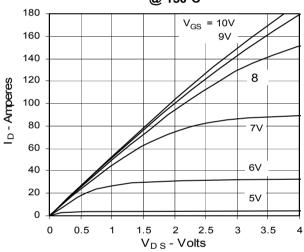


Fig. 5. $R_{DS(on)}$ Normalized to 0.5 I_{D25} Value vs. Drain Current

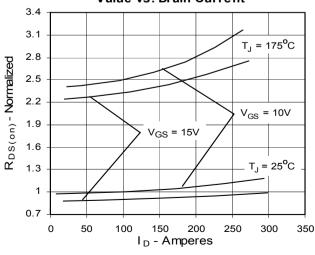


Fig. 2. Extended Output Characteristics @ 25°C

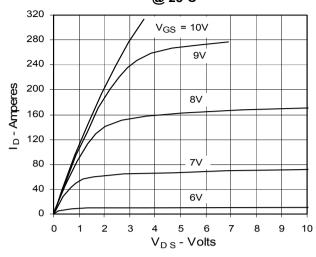


Fig. 4. $R_{DS(on)}$ Normalized to 0.5 I_{D25} Value vs. Junction Temperature

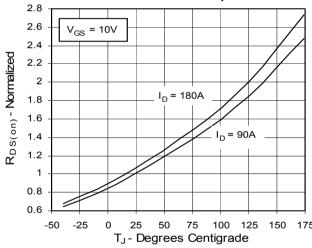
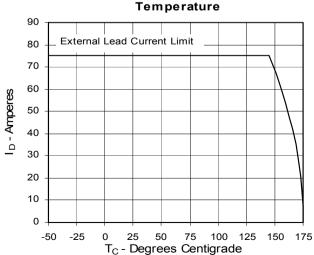


Fig. 6. Drain Current vs. Case
Temperature





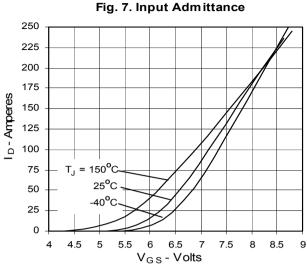
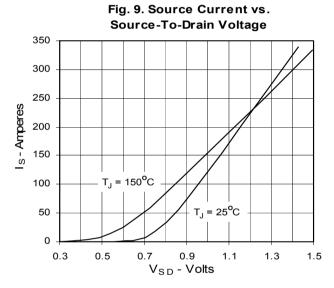
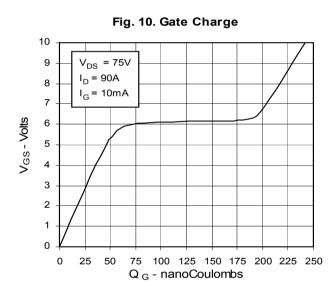
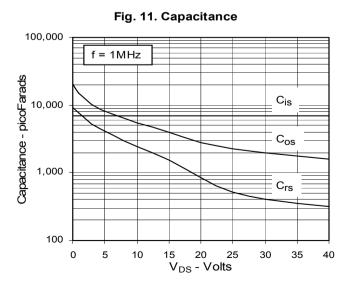




Fig. 8. Transconductance 120 $T_{J} = -40^{\circ}C$ 100 25°C 150°C g fs - Siemens 80 60 40 20 0 0 25 50 75 100 125 150 175 200 225 250 I_D - Amperes







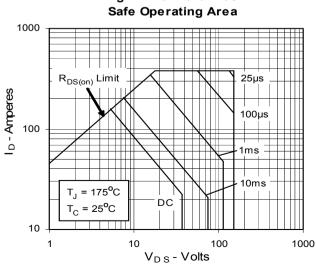


Fig. 12. Forward-Bias

IXYS reserves the right to change limits, test conditions, and dimensions.



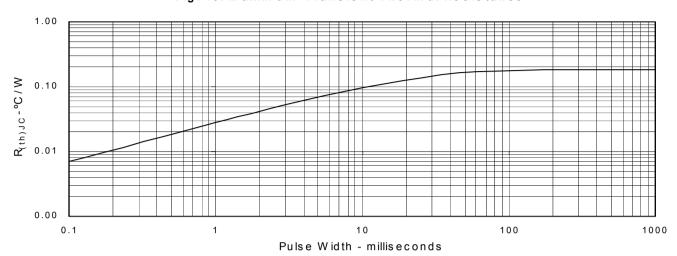


Fig. 13. Maximum Transient Thermal Resistance

